IGBT - Field Stop, Trench, Soft Fast Recovery Diode

650 V, 160 A

FGY160T65SPD-F085

ON Semiconductor®

www.onsemi.com

Benefits

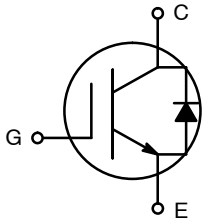
- Very Low Conduction and Switching Losses for a High Efficiency Operation in Various Applications
- Rugged Transient Reliability
- Outstanding Parallel Operation Performance with Balance Current Sharing
- Low EMI

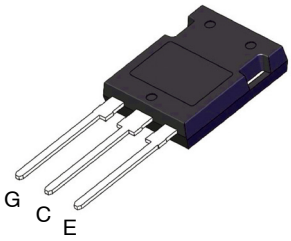
Features

- AEC−Q101 Qualified and PPAP Capable
- Very Low Saturation Voltage: $V_{CE(sat)}$ = 1.6 V (Typ.) @ I_C = 160 A
- Maximum Junction Temperature: T_J = 175°C
- Positive Temperature Co−Efficient
- Tight Parameter Distribution
- High Input Impedance
- 100% of the Parts are Dynamically Tested
- Short circuit ruggedness > 6 μs @ 25°C
- Copacked with Soft, Fast Recovery Extremefast Diode
- This Device is Pb−Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

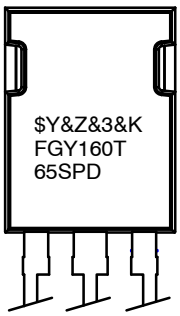
- Traction Inverter for HEV/EV
- Auxiliary DC/AC Converter
- Motor Drives
- Other Power−Train Applications Requiring High Power Switch





TO−247−3LD
CASE 340CU

MARKING DIAGRAM



&Y	= ON Semiconductor Logo
&Z	= Assembly Plant Code
&3	= Data Code (Year & Week)
&K	= Lot
FGY160T65SPD	= Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Ratings	Unit
V_{CES}	Collector to Emitter Voltage	650	V
V_{GES}	Gate to Emitter Voltage	±20	V
	Transient Gate to Emitter Voltage	±30	V
I_C	Collector Current @ T_C = 25°C (Note 1)	240	A
	Collector Current @ T_C = 100°C	220	A
$I_{Nominal}$	Nominal Current	160	A
I_{CM}	Pulsed Collector Current	480	A
I_{FM}	Diode Forward Current @ T_C = 25°C (Note 1)	240	A
	Diode Forward Current @ T_C = 100°C	188	A
P_D	Maximum Power Dissipation @ T_C = 25°C	882	W
	Maximum Power Dissipation @ T_C = 100°C	441	W
SCWT	Short Circuit Withstand Time @ T_C = 25°C	6	μs
$\Delta V/\Delta t$	Voltage Transient Ruggedness (Note 2)	10	V/ns
T_J	Operating Junction Temperature	−55 to +175	°C
T_{stg}	Storage Temperature Range	−55 to +175	°C
T_L	Maximum Lead Temp. for soldering Purposes, 1/8” from case for 5 seconds	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Limited to bondwire.
2. V_{CC} = 400 V, V_{GE} = 15 V, I_{CE} = 480 A, Inductive load.

THERMAL CHARACTERISTICS

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$ (IGBT)	Thermal Resistance, Junction to Case	–	0.17	°C/W
$R_{\theta JC}$ (Diode)	Thermal Resistance, Junction to Case	–	0.32	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	–	40	°C/W

PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Packing Type	Qty per Tube
FGY160T65SPD	FGY160T65SPD−F085	TP−247−3LD	Tube	30 ea

ELECTRICAL CHARACTERISTICS OF THE IGBT (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
OFF CHARACTERISTICS						
BV_{CES}	Collector to Emitter Breakdown Voltage	V_{GE} = 0 V, I_C = 1 mA	650	–	–	V
$\Delta BV_{CES}/\Delta T_J$	Temperature Coefficient of Breakdown Voltage	V_{GE} = 0 V, I_C = 1 mA	–	0.6	–	V/°C
I_{CES}	Collector Cut-Off Current	V_{CE} = V_{CES}, V_{GE} = 0 V	–	–	40	μA
I_{GES}	G−E Leakage Current	V_{GE} = V_{GES}, V_{CE} = 0 V	–	–	±250	nA
ON CHARACTERISTICS						
$V_{GE(th)}$	G−E Threshold Voltage	I_C = 160 mA, V_{CE} = V_{GE}	4.3	5.3	6.3	V
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	I_C = 160 A, V_{GE} = 15 V	–	1.6	2.05	V
		I_C = 160 A, V_{GE} = 15 V, T_J = 175°C	–	2.15	–	V

ELECTRICAL CHARACTERISTICS OF THE IGBT (T_J = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
DYNAMIC CHARACTERISTICS						
C_{ies}	Input Capacitance	V_{CE} = 30 V, V_{GE} = 0 V, f = 1 MHz	–	6710	–	pF
C_{oes}	Output Capacitance		–	450	–	pF
C_{res}	Reverse Transfer Capacitance		–	55	–	pF
R_G	Internal Gate Resistance	f = 1 MHz	–	3	–	Ω
SWITCHING CHARACTERISTICS						
$T_{d(on)}$	Turn-On Delay Time	V_{CC} = 400 V, I_C = 160 A, R_G = 5 Ω, V_{GE} = 15 V, Inductive Load, T_J = 25°C	–	53	–	ns
T_r	Rise Time		–	197	–	ns
$T_{d(off)}$	Turn-Off Delay Time		–	98	–	ns
T_f	Fall Time		–	141	–	ns
E_{on}	Turn-On Switching Loss		–	12.4	–	mJ
E_{off}	Turn-Off Switching Loss		–	5.7	–	mJ
E_{ts}	Total Switching Loss		–	18.1	–	mJ
$T_{d(on)}$	Turn-On Delay Time	V_{CC} = 400 V, I_C = 160 A, R_G = 5 Ω, V_{GE} = 15 V, Inductive Load, T_J = 175°C	–	52	–	ns
T_r	Rise Time		–	236	–	ns
$T_{d(off)}$	Turn-Off Delay Time		–	104	–	ns
T_f	Fall Time		–	204	–	ns
E_{on}	Turn-On Switching Loss		–	21	–	mJ
E_{off}	Turn-Off Switching Loss		–	8.5	–	mJ
E_{ts}	Total Switching Loss		–	29.5	–	mJ
Q_g	Total Gate Charge	V_{CE} = 400 V, I_C = 160 A, V_{GE} = 15 V	–	163	245	nC
Q_{ge}	Gate to Emitter Charge		–	50	–	nC
Q_{gc}	Gate to Collector Charge		–	49	–	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ELECTRICAL CHARACTERISTICS OF THE DIODE (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions		Min.	Typ.	Max.	Unit
V_{FM}	Diode Forward Voltage	I_F = 160 A	T_J = 25°C	–	1.4	1.7	V
			T_J = 175°C	–	1.35	–	
E_{rec}	Reverse Recovery Energy	V_{CE} = 400 V, I_F = 160 A, $\Delta I_F/\Delta t$ = 1000 A/μs	T_J = 25°C	–	598	–	μJ
			T_J = 175°C	–	4000	–	
T_{rr}	Diode Reverse Recovery Time		T_J = 25°C	–	132	–	ns
			T_J = 175°C	–	245	–	
Q_{rr}	Diode Reverse Recovery Charge		T_J = 25°C	–	3.3	–	μC
			T_J = 175°C	–	12.5	–	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL PERFORMANCE CHARACTERISTICS

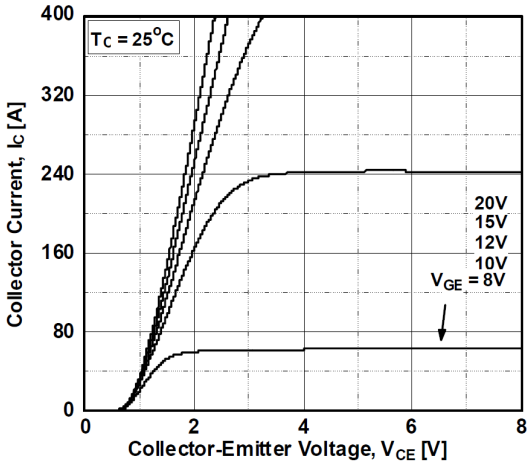


Figure 1. Typical Output Characteristics

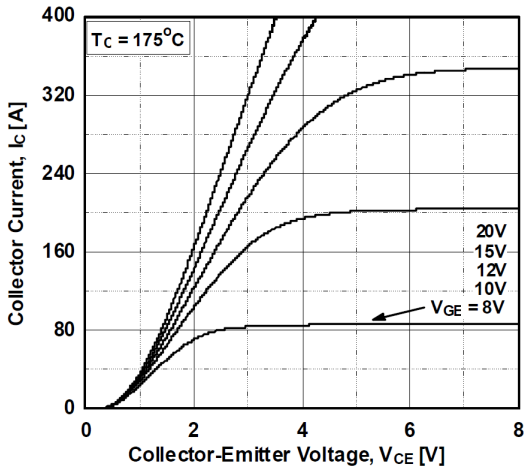


Figure 2. Typical Output Characteristics

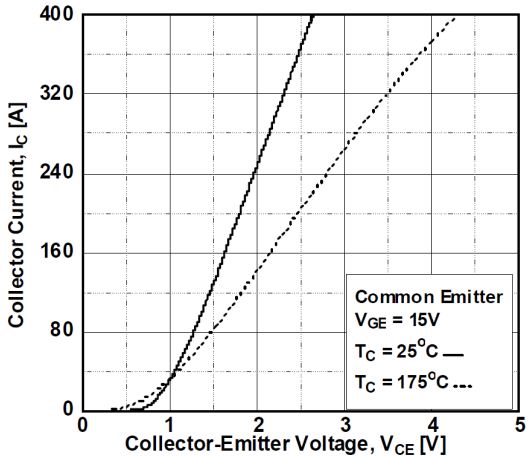


Figure 3. Typical Saturation Voltage Characteristics

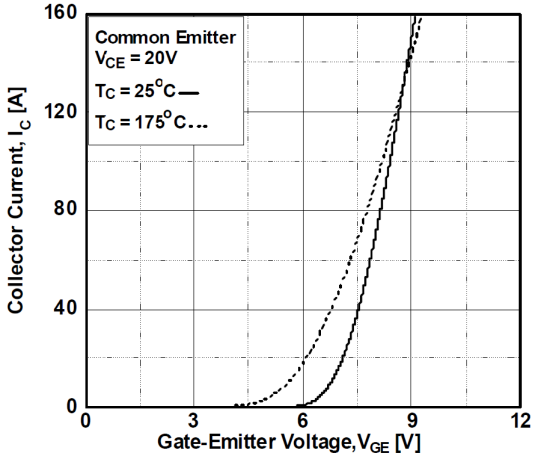


Figure 4. Transfer Characteristics

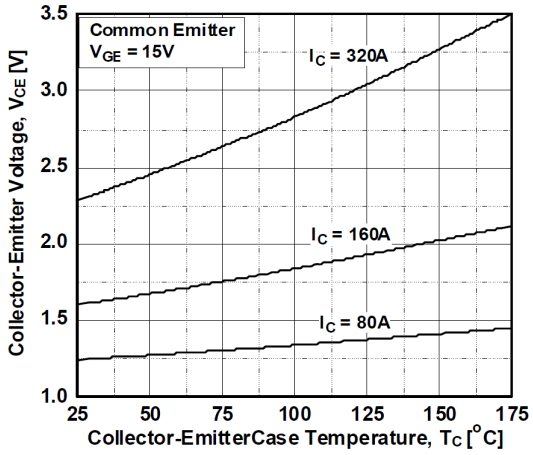


Figure 5. Saturation Voltage vs. Case Temperature at Variant Current Level

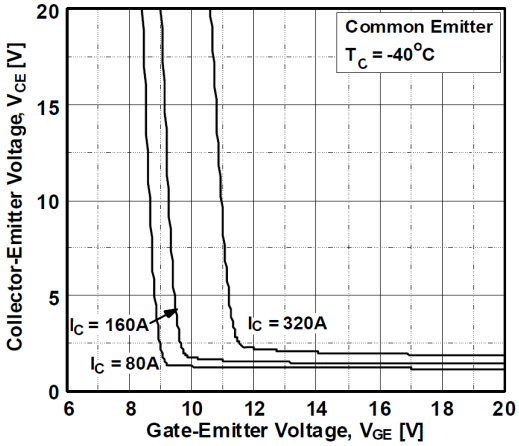


Figure 6. Saturation Voltage vs. V_{GE}

TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

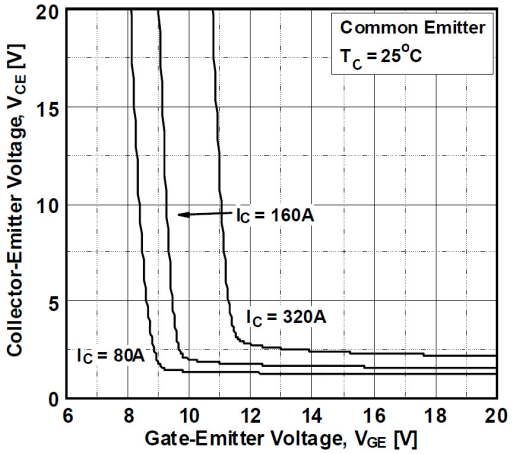


Figure 7. Saturation Voltage vs. V_{GE}

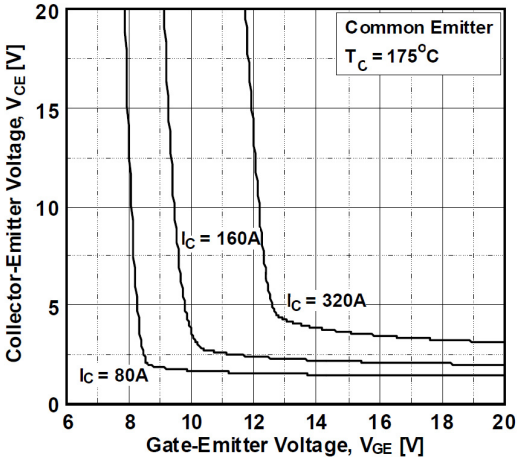


Figure 8. Saturation Voltage vs. V_{GE}

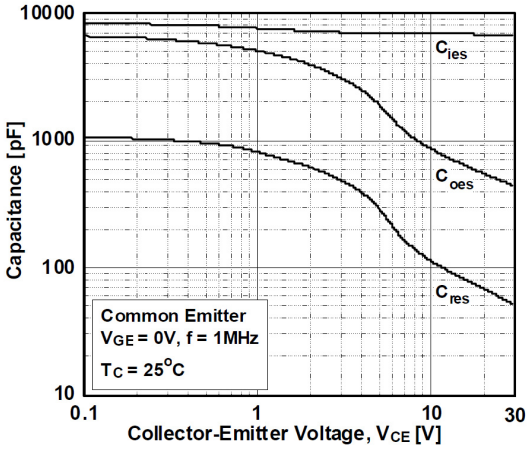


Figure 9. Capacitance Characteristics

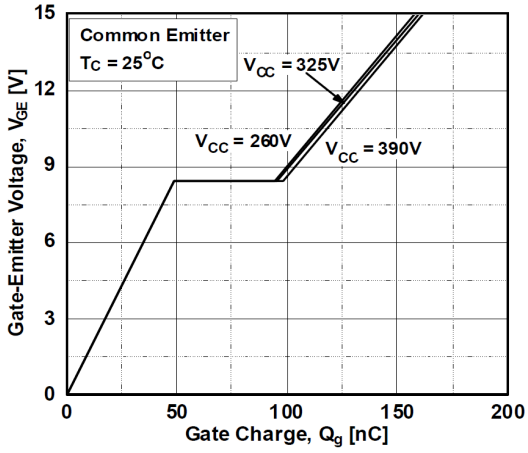


Figure 10. Gate Charge Characteristics

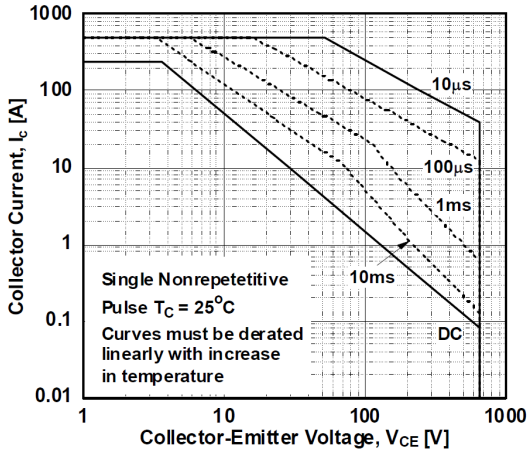


Figure 11. SOA Characteristics

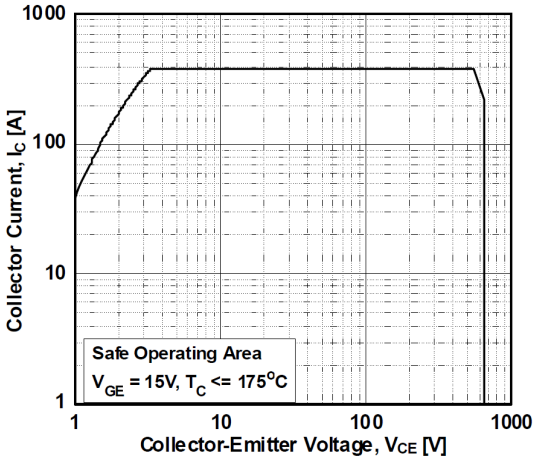


Figure 12. Turn Off Switching SOA Characteristics

TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

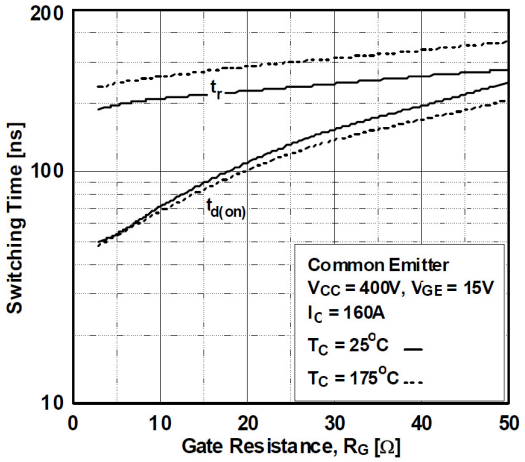


Figure 13. Turn−on Characteristics vs. Gate Resistance

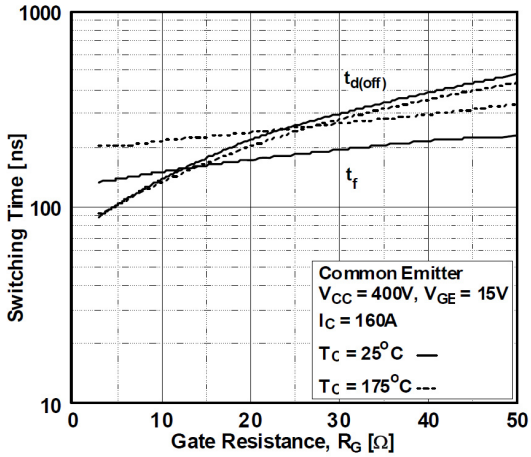


Figure 14. Turn−off Characteristics vs. Gate Resistance

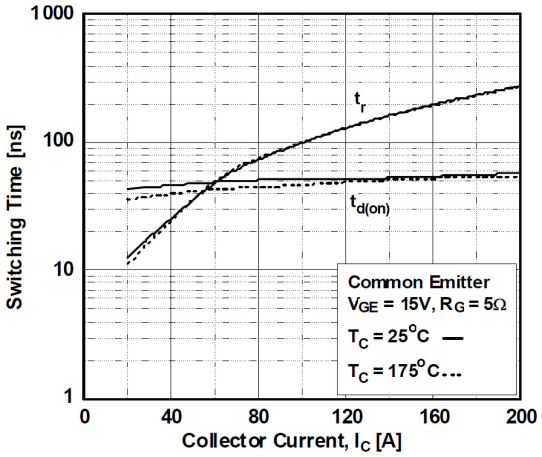


Figure 15. Turn−on Characteristics vs. Collector Current

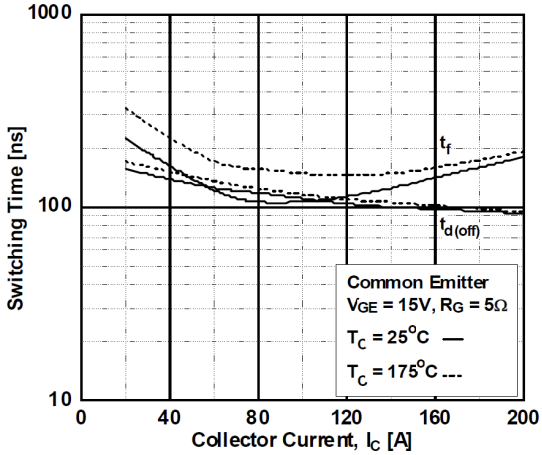


Figure 16. Turn−off Characteristics vs. Collector Current

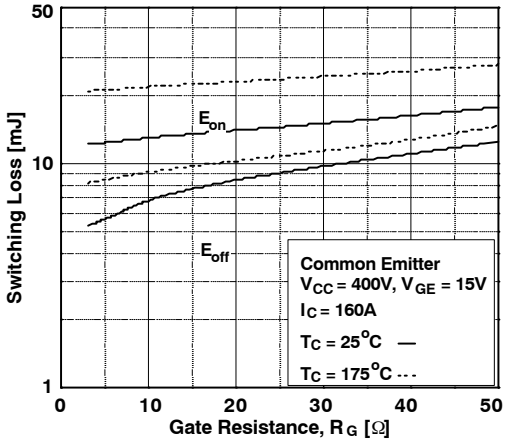


Figure 17. Switching Loss vs. Gate Resistance

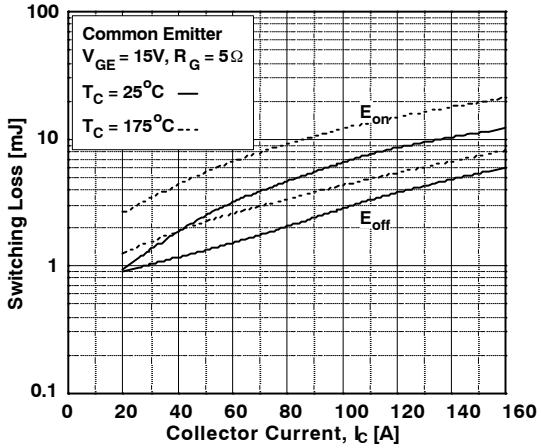


Figure 18. Switching Loss vs. Collector Current

TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

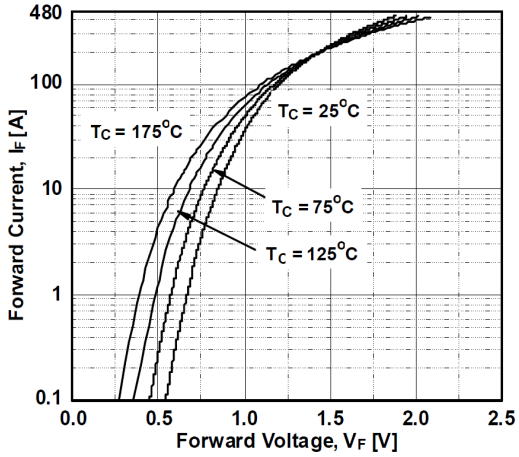


Figure 19. Forward Characteristics

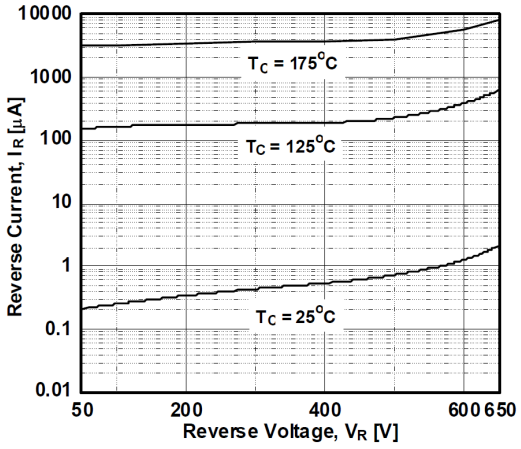


Figure 20. Reverse Current

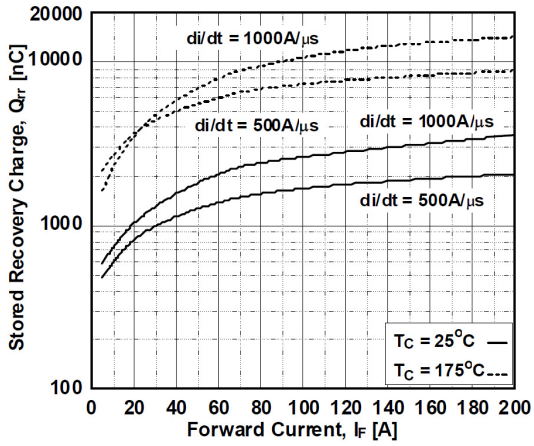


Figure 21. Stored Charge

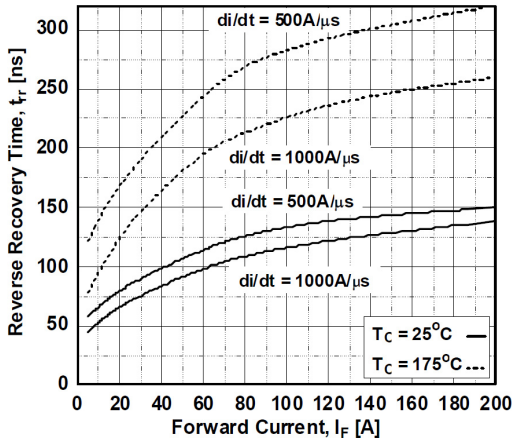


Figure 22. Reverse Recovery Time

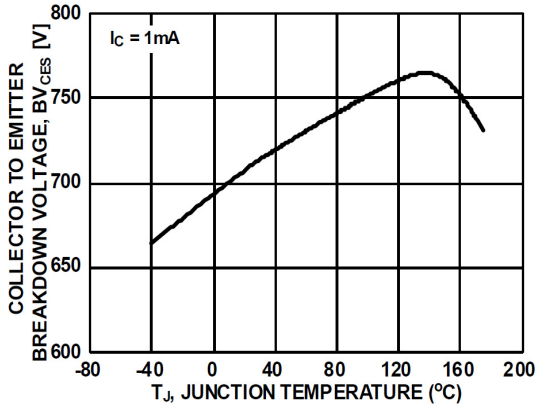


Figure 23. Collector to Emitter Breakdown Voltage vs. Junction Temperature

TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

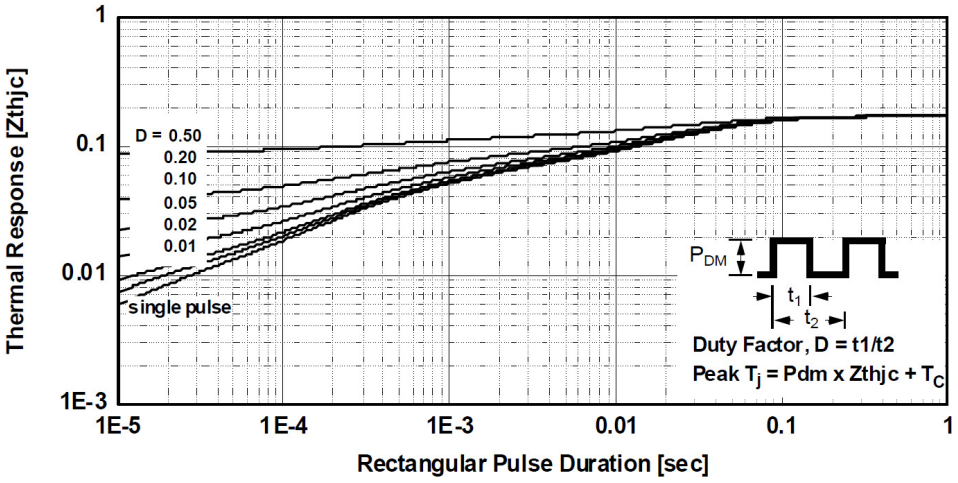


Figure 24. Transient Thermal Impedance of IGBT

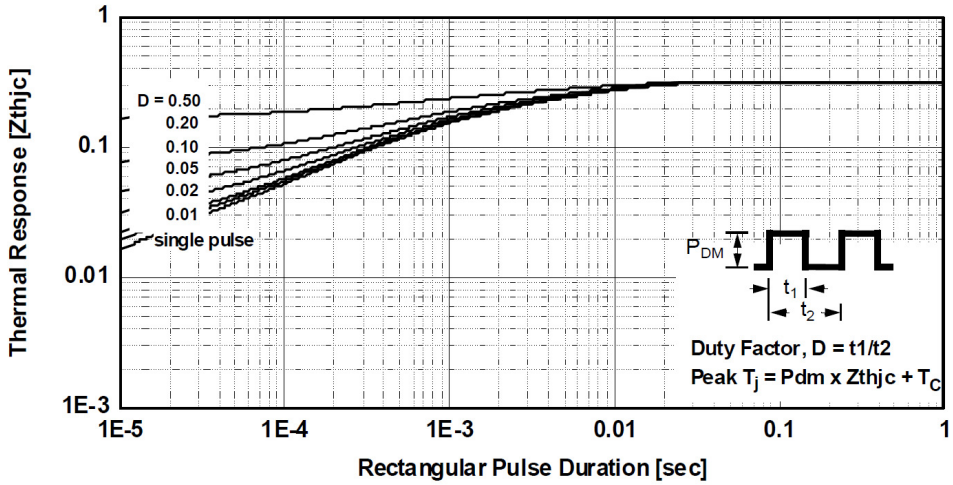


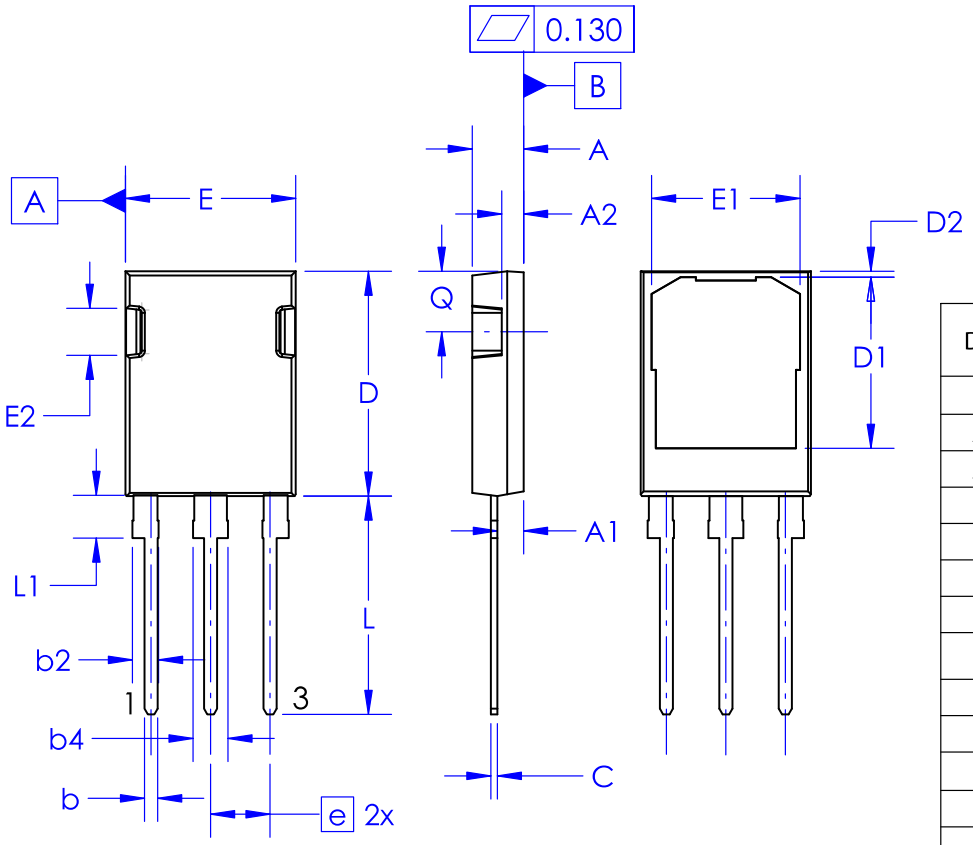
Figure 25. Transient Thermal Impedance of Diode

MECHANICAL CASE OUTLINE
PACKAGE DIMENSIONS

ON Semiconductor®

TO−247−3LD
CASE 340CU
ISSUE A

DATE 16 SEP 2019



DIM	MILLIMETERS		
	MIN	NOM	MAX
A	4.50	4.70	4.90
A1	2.10	2.40	2.70
A2	1.70	2.00	2.30
b	1.00	1.20	1.400
b2	2.20	2.40	2.60
b4	3.00	3.20	3.40
c	0.40	0.60	0.80
D	20.40	20.60	20.80
D1	15.47	15.67	15.87
D2	0.25	0.55	0.85
e	5.45 BSC		
E	15.40	15.60	15.80
E1	13.40	13.60	13.80
E2	4.12	4.30	4.52
L	19.70	20.00	20.30
L1	3.65	3.85	4.05
Q	5.35	5.55	5.75

NOTES:

A. NO INDUSTRY STANDARS APPLIES TO THIS PACKAGE.
B. ALL DIMENSIONS ARE IN MILLIMETERS.
C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.
D. DRAWING CONFORMS TO ASME Y14.5-2009.

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